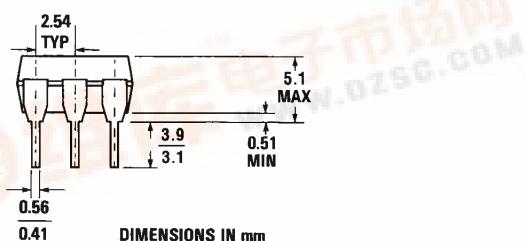
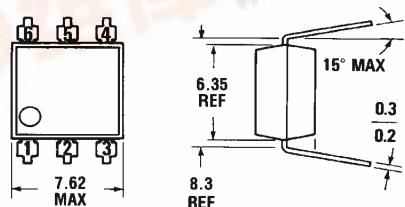
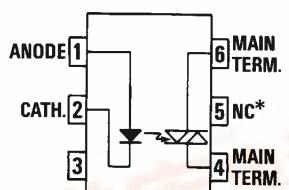




NON-ZERO-CROSSING TRIACS

**MOC3009 MOC3010
MOC3011 MOC3012**
PACKAGE DIMENSIONSDIMENSIONS IN mm
PACKAGE CODE E

ST1603-02

*DO NOT CONNECT
(TRIAC SUBSTRATE)

Equivalent Circuit

ABSOLUTE MAXIMUM RATINGS**TOTAL PACKAGE**

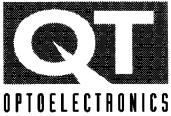
Storage temperature	-55°C to 150°C
Operating temperature	-40°C to 100°C
Lead temperature (soldering 10 sec)	260°C
Withstand test voltage ...	7500 VAC Peak (50-60 Hz)

INPUT DIODE

Forward DC current	50 mA
Reverse voltage	3 V
Peak forward current (1 μs pulse, 300 pps)	3.0 A
Power dissipation (25°C ambient)	100 mW
Derate linearly (above 25°C)	1.33 mW/°C

OUTPUT DRIVER

Off-state output terminal voltage	250 volts
On-state RMS current $T_A=25^\circ\text{C}$	100 mA
(Full cycle, 50 to 60 Hz) $T_A=70^\circ\text{C}$	50 mA
Peak nonrepetitive surge current	1.2 A
(PW=10 ms, DC=10%)	
Total power dissipation @ $T_A=25^\circ\text{C}$	300 mW
Derate above 25°C	4.0 mW/°C



NON-ZERO-CROSSING TRIACS

ELECTRO-OPTICAL CHARACTERISTICS (25°C Temperature Unless Otherwise Specified)

INDIVIDUAL COMPONENT CHARACTERISTICS						
CHARACTERISTIC	SYMBOL	MIN.	TYP.	MAX.	UNITS	TEST CONDITIONS
INPUT DIODE						
Forward voltage	V_F	1.2	1.50		V	$I_F = 10 \text{ mA}$
Junction capacitance	C_J	50			pF	$V_F = 0 \text{ V}, f = 1 \text{ MHz}$
Reverse leakage current	I_R		100		μA	$V_R = 3.0 \text{ V}$
OUTPUT DETECTOR						
Peak blocking current, either direction	I_{DRM}	—		100	nA	$V_{DRM} = 250 \text{ V}$, Note 1
Peak on-state voltage, either direction	V_{TM}	—	2.0	3.0	Volts	$I_{TM} = 100 \text{ mA Peak}$

Note 1. Test voltage must be applied within dv/dt rating.

TRANSFER CHARACTERISTICS						
DC CHARACTERISTICS	SYMBOL	MIN.	TYP.	MAX.	UNITS	TEST CONDITIONS
LED trigger current (current required to latch output)	MOC3009	I_{FT}	—	15.0	mA	Main terminal
	MOC3010	I_{FT}	—	10.0	mA	voltage = 3.0 V, $R_L = 150\Omega$
	MOC3011	I_{FT}	—	5	mA	
	MOC3012	I_{FT}	—	—	mA	
Holding current	I_H	—	100	—	μA	Either direction

TRANSFER CHARACTERISTICS						
CHARACTERISTICS	SYMBOL	MIN.	TYP.	MAX.	UNITS	TEST CONDITIONS
AC dv/dt RATING						
Critical rate of rise of off-state voltage	dv/dt	—	12.0	—	V/ μs	Static dv/dt (see Fig. 4)
Critical rate of rise of commutating voltage	dv/dt	—	0.2	—	V/ μs	Commutating dv/dt $I_{LOAD} = 15 \text{ mA}$ (see Fig. 4)

ISOLATION CHARACTERISTICS						
CHARACTERISTICS	SYMBOL	MIN.	TYP.	MAX.	UNITS	TEST CONDITIONS
Isolation voltage	V_{iso}	5300			$V_{AC}RMS$	$I_{IO} \leq 1 \mu\text{A}, 1 \text{ Minute}$
	V_{iso}	7500			$V_{AC}PEAK$	$I_{IO} \leq 1 \mu\text{A}, 1 \text{ Minute}$
Isolation resistance	R_{iso}	10^{11}			ohms	$V_{IO} = 500 \text{ VDC}$
Isolation capacitance	C_{iso}		0.5		pF	$f = 1 \text{ MHz}$



NON-ZERO-CROSSING TRIACS

TYPICAL ELECTRICAL CHARACTERISTIC CURVES (25°C Free Air Temperature Unless Otherwise Specified)

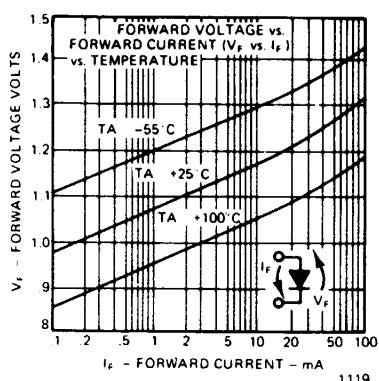


Fig. 1. Forward Voltage Drop vs. Forward Current

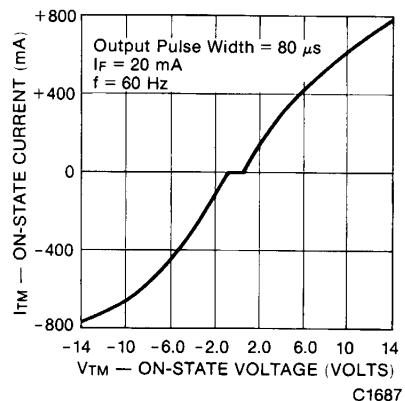


Fig. 2. On-State Characteristics

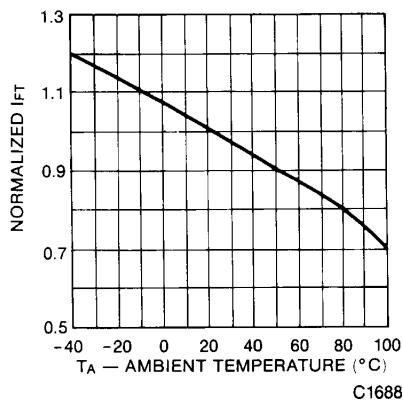


Fig. 3. Trigger Current vs. Temperature

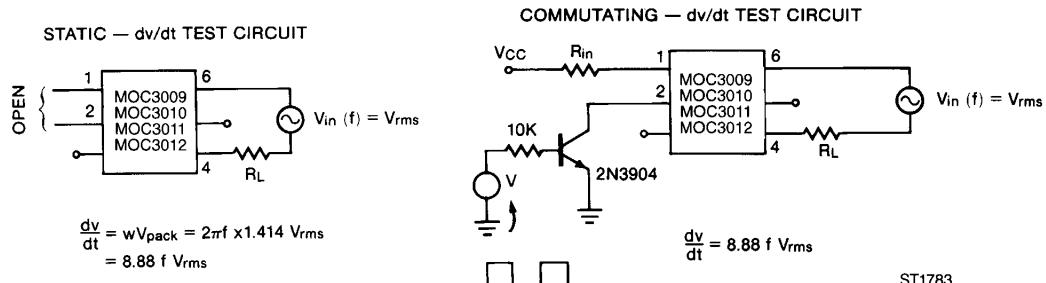
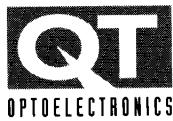
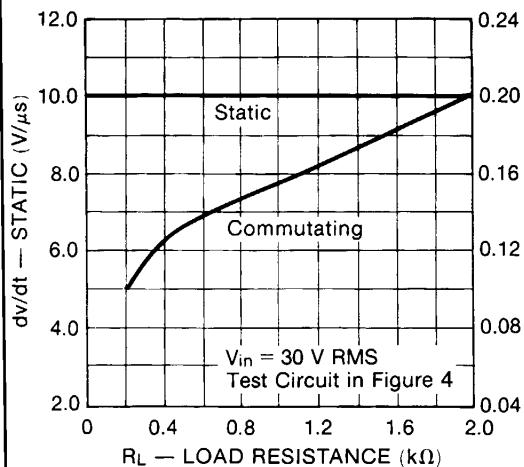


Fig. 4. dV/dt Test Circuits

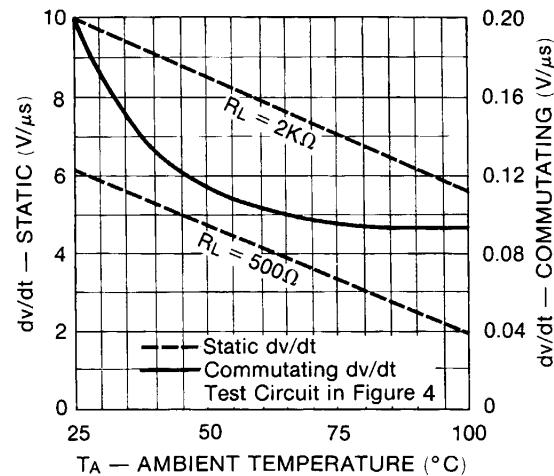


NON-ZERO-CROSSING TRIACS

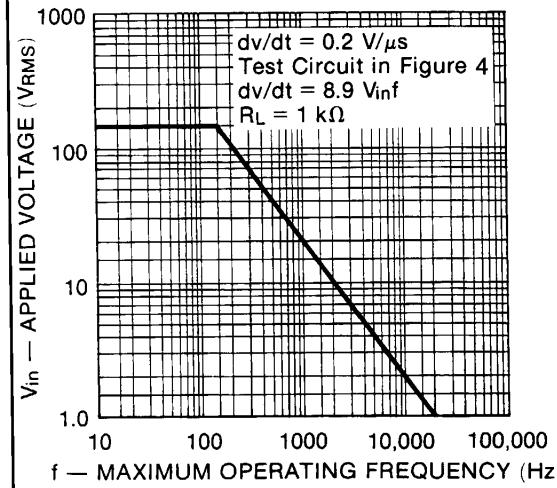
TYPICAL ELECTRICAL CHARACTERISTIC CURVES (25°C Free Air Temperature Unless Otherwise Specified) (Cont'd)



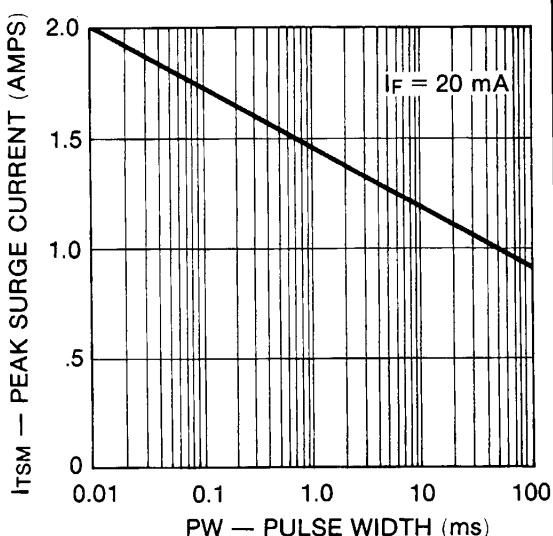
C1690

Fig. 5. dV/dt vs. Load Resistance

C1691

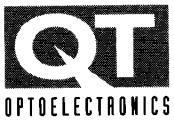
Fig. 6. dV/dt vs. Temperature

C1692

Fig. 7. Commutating dV/dt vs. Frequency

C1696

Fig. 8. Maximum Nonrepetitive Surge Current



NON-ZERO-CROSSING TRIACS

TYPICAL APPLICATION CIRCUITS

